

<b>Notice of References Cited</b>	Application/Control No. 10/719,521	Applicant(s)/Patent Under Reexamination TAKEUCHI ET AL.	
	Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,198,225	03-2001	Kano et al.	315/169.3
	B	US-6,184,610	02-2001	Shibata et al.	313/309
	C	US-6,025,819	02-2000	Xie et al.	345/75.1
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

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